Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	64313	g06f015/00.ipc.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2006/01/03 15:13
L2	19075	g06f011/30.ipc.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2006/01/03 15:13
L5	766	(l1 l2) and ((time near3 (study analysis)))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/01/03 15:16
L7	125	(l1 l2) and ((time near3 (study analysis))) and ((icon ((graphical pictorial) adj (rendering depiction representation))))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/01/03 15:17
S63	12	lander-r.in.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2006/01/03 11:54
S98	33	S97 and ((time time$motion) with (study analysis analyses studies studying analysing analyzing research investigation))	USPAT	OR	ON	2006/01/03 07:20
S99	210	((time time$motion) near4 (study analysis examination)) and (selectable selection selected chose choose choosing chosen choice select selecting opt opting option chooseable) and ((generic general typical conventional) near3 (icon pictographic symbol))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/01/03 08:36
S100	3929	((time time$motion) near4 (study analysis examination)) and ((generic general typical conventional) near3 (icon pictographic symbol description character))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/01/03 08:16
S101	70	"715"/$.ccls. and ((time time$motion) near4 (study analysis examination)) and ((generic general typical conventional) near3 (icon pictographic symbol description character))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/01/03 08:25

S102	190	"702"/$.ccls. and ((time time$motion) near4 (study analysis examination)) and ((generic general typical conventional) near3 (icon pictographic symbol description character))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/01/03 08:30
S103	30	(time adj (study analysis)) and ((generic general) adj (icon symbol character))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/01/03 08:32
S104	30	(time near3 (study analysis)) and chronometer	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/01/03 10:01
S105	32	(generic near3 (task action)) and ((create apply associate link) near4 (icon (pictorial adj representation)))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/01/03 10:36
S106	17	icon and chronometer	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/01/03 10:41
S107	232	(time near3 study) and icon	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/01/03 10:43
S108	32	(time adj study) and icon	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/01/03 10:45
S109	23	(time adj study) with (computer processor microcomputer microprocessor chronometer)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/01/03 10:46
S110	348	702/127.ccls.	US-PGPUB; USPAT	OR	OFF	2006/01/03 11:36
S111	310	702/176.ccls.	US-PGPUB; USPAT	OR	OFF	2006/01/03 11:37
S112	162	702/178.ccls.	US-PGPUB; USPAT	OR	OFF	2006/01/03 11:37

S113	1098	702/182.ccls.	US-PGPUB; USPAT	OR	OFF	2006/01/03 11:37
S114	409	702/187.ccls.	US-PGPUB; USPAT	OR	OFF	2006/01/03 11:37
S115	347	715/839.ccls.	US-PGPUB; USPAT	OR	OFF	2006/01/03 11:38
S116	353	(S110 S111 S112 S113 S114 S115) and (chronometer (time near3 (study analysis))) (clock near3 (application program firmware software algorithm)))	US-PGPUB; USPAT	OR	ON	2006/01/03 11:49
S117	55	(S110 S111 S112 S113 S114 S115) and (chronometer (time near3 (study analysis))) (clock near3 (application program firmware software algorithm))) and (icon ((pictorial graphical) adj (depiction representation rendering)))	US-PGPUB; USPAT	OR	ON	2006/01/03 11:50
S118	295	(S110 S111 S112 S113 S114 S115) and (chronometer (time near3 (study analysis)))	US-PGPUB; USPAT	OR	ON	2006/01/03 11:49
S119	74	(S110 S111 S112 S113 S114 S115) and ((time performance efficiency) near3 (study analysis)) and (icon ((pictorial graphical) adj (depiction representation rendering)))	US-PGPUB; USPAT	OR	ON	2006/01/03 11:52
S120	4	lander-ronald.in.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2006/01/03 11:54
S121	13	lander-r.in.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2006/01/03 11:54
S122	634	lander.in.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	OFF	2006/01/03 11:54
S123	336	chronometer and (computer microprocessor microcomputer processor (graphical adj user adj interface) (digital adj signal adj processor) (programmable adj logic adj (unit system device)))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT ; IBM_TDB	OR	ON	2006/01/03 11:59

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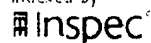
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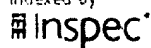|	
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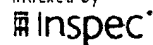» **Organize results**
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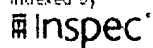IEEE CNF   IEEE Conference   **No results were found.**
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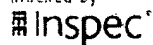   Maximum 100
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Chao, H.H.; Havreluk, R.P.;
Electron Devices, IEEE Transactions on
Volume 27, Issue 11, Nov 1980 Page(s):2183 - 2183
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□   2. **Continuing education around the world**
Klus, J.P.; Jones, J.A.;
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Volume 66, Issue 8, Aug. 1978 Page(s):956 - 961
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□   3. **Shallow phosphorus diffusion profiles in silicon**
Tsai, J.C.C.;
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□   4. **Delay time studies and electron mobility measurement in a-Si:H TFT**
Bashir, R.; Subramanian, C.K.; Neudeck, G.W.; Chung, K.Y.;
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Volume 36, Issue 12, Dec. 1989 Page(s):2944 - 2948
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□   5. **Recent MCNP developments**
Hendricks, J.S.; Briesmeister, J.F.;
Nuclear Science, IEEE Transactions on
Volume 39, Issue 4, Aug 1992 Page(s):1035 - 1040
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□   6. **Time varying load analysis to reduce distribution losses through reconfi**
Broadwater, R.P.; Khan, A.H.; Shaalan, H.E.; Lee, R.E.;
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Volume 8, Issue 1, Jan. 1993 Page(s):294 - 300
Digital Object Identifier 10.1109/61.180349

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7. **Methods for onset detection of voluntary motor responses in tremor pati**
Staude, G.H.; Wolf, W.M.; Appel, U.; Dengler, R.;
Biomedical Engineering, IEEE Transactions on
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Digital Object Identifier 10.1109/10.481987

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8. **Radiation induced trap levels in SIMOX oxides: low temperature thermall**
luminescence
Martini, M.; Meinardi, F.; Rosetta, E.; Spinolo, G.; Vedda, A.; Leray, J.L.; Paille
Devine, R.A.B.;
Nuclear Science, IEEE Transactions on
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9. **Image quality evaluation based on recognition times for fast image brows**
Schilling, D.; Cosman, P.C.;
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Digital Object Identifier 10.1109/TMM.2002.802844

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10. **Properties of two-mode, elliptical-core fibre gratings**
Greene, J.A.; Vengsarkar, A.M.; Murphy, K.A.;
Electronics Letters
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11. **Positioning and Timing Study of GPS C/A Code Receivers**
Qixiang Zhuang; Klepczynski, W.J.; Lukac, C.F.;
Frequency Control, 41st Annual Symposium on. 1987
1987 Page(s):130 - 143

AbstractPlus | Full Text: PDF(712 KB)   IEEE CNF

12. **Efficient dynamics for a PUMA-600**
Leahy, M.; Nugent, L.; Valavanis, K.; Saridis, G.;
Robotics and Automation. Proceedings. 1986 IEEE International Conference c
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13. **On the supervision and assessment of part-time postgraduate software ε**
projects
Simpson, A.; Martin, A.; Gibbons, J.; Davies, J.; McKeever, S.;
Software Engineering, 2003. Proceedings. 25th International Conference on
3-10 May 2003 Page(s):628 - 633
Digital Object Identifier 10.1109/ICSE.2003.1201247

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14. **Real-time studies of nucleation and interface formation in microcrystallir**
Fujiwara, H.; Kondo, M.; Matsuda, A.;
Photovoltaic Energy Conversion, 2003. Proceedings of 3rd World Conference
Volume 3, 12-16 May 2003 Page(s):2761 - 2766 Vol.3
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15. **Real-time studies of strain relaxation in InGaAs heteroepitaxy**
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Compound Semiconductors, 2003. International Symposium on
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16. **Gate oxide breakdown on low noise and power amplifier performance**
Hong Yang; Smith, W.; Yuan, J.S.;
Radio Frequency Integrated Circuits (RFIC) Symposium, 2003 IEEE
8-10 June 2003 Page(s):663 - 666

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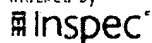
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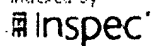| IEEE JNL | IEEE Journal or Magazine |
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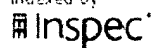| IEEE JNL | IEEE Journal or Magazine |
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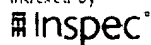
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